REPORT OF SPECIAL TEST

NIST Test No: 683/282470-12 May 31, 2012

For:

Wilcox Associates, Inc.

2632 Kettle Court

West Bend, WI 53090 USA

Attn: Tim Wernicke

Item: PC-DMIS 2012 Release

The least-squares fitting features of this software package was tested on 240 data sets, representing the following geometry types: lines, lines 2D, circles, circles 2D, planes, spheres, cylinders, and cones. The test procedures followed are documented in ASME B89.4.10-2000 and NISTIR 5686.

The uncertainties associated with the reference values were evaluated following NIST Technical Note 1297, Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results, which is considered to be part of this Report. The expanded uncertainty U is calculated using a coverage factor k = 2. For a measured value of length (or angular measure), L, the true length (or angular measure) is contained in the interval [L-U, L+U with a level of confidence of approximately 95 %. The results of the test are as follows:

ASME B89.4.10-2000 Standard Default Test

Geometry Type	Mean (RMS) Deviation						
	Separation (µm)	Tilt (arc seconds)	Radius/dist (µm)	Apex (arc seconds)			
Lines	< 10 ⁻⁵	< 10 ⁻⁷		_			
Lines 2D	< 10 ⁻⁵	< 10 ⁻⁷					
Planes	< 10 ⁻⁵	6 × 10 ⁻⁶		particle processing and the second processin			
Circles	4×10^{-5}	2.8×10^{-6}	3 × 10 ⁻⁵	-			
Circles 2D	7×10^{-5}	2.2×10^{-6}	6 × 10 ⁻⁵	-			
Spheres	2.5×10^{-4}		1×10^{-4}				
Cylinders	< 10 ⁻⁵	1.7×10^{-4}	< 10 ⁻⁵	_			
Cones	1.9×10^{-2}	2.4×10^{-1}	1 × 10 ⁻²	4×10^{-2}			

In each of the results above, the NIST (k=2) expanded uncertainty, U, is less than 1.0 x 10⁻⁹ µm or arc seconds, as applicable. This is due in part to the fact that the NIST reference results were calculated using precision that is much better than usual double precision computations.

Page 1 of 5



Data sets for the categories "Lines 2D" and "Circles 2D" are restricted to two-dimensions. That is, all the data points lie within a plane, and that plane is parallel to one of the x-y, y-z, or z-x coordinate planes. Data points for all other geometries are not restricted to any plane.

The test conditions, particularly the specifications for the test data sets, comply with the default test specified in Standard ASME B89.4.10-2000 (Reference 1). Some conditions are summarized as:

Sampling strategy	Points were regularly spaced over the sampling region.		
Measurement error	Uniformly random measurement error simulations were included.		
Form errors	Several errors specified in the standard, including bends, sinusoidal, step errors, tapers, etc.		
Range of part size	1 mm to 500 mm.		
Part origin	Within 1000 mm of coordinate system origin.		
Aspect ratios	Planes: maximum length:width ratio was 50. Cylinders and Cones: aspect ratios between 0.02 and 10.		
Partial features	Circles: arcs as small as 90°. Spheres: hemispheres, 90° polar patches, and 30° bands. Cylinders and Cones: 90° to 360° sweeps.		

For applications of the software that are within the scope of the test conditions described above, the root mean square (RMS) value given in the table of results is a reasonable evaluation of the fitting software's standard uncertainty contribution to the uncertainty of a corresponding measurement.

While the coordinates in the test data sets are in millimeters, the results are reported in micrometers for lengths and in arc seconds for angles. The values reported in this Report of Special Test apply to the software tested only in the computing environment in which it was tested. NIST cannot guarantee that the user's software will have the same value as reported by NIST when used in another facility at a later date.

This Special Test was carried out as follows: NIST generated data sets simulating the ranges of test conditions described above in accordance with the ASME B89.4.10-2000 Standard. NIST also generated reference fit results using NIST's Algorithm Testing System internal algorithms. The customer received the NIST-generated data sets in ASCII format and generated corresponding fit results using the software under test. NIST then compared each of the customer's fits to the reference fit for the corresponding data set

Special Test Date: May 31, 2012

Page 2 of 5

using procedures set forth in the Standard. The reported test results for each geometry type are the RMS value deviations between the customer's fits and the reference fits for all data sets corresponding to that geometry type. According to the Standard, when deviation results are less than 10^{-5} µm or 10^{-7} arc seconds, these values are reported as "< 10^{-5} " and "< 10^{-7} ."

The following table displays the maximum observed error (deviation) of each evaluation parameter for each geometric feature type.

Geometry Type	Maximum Observed Deviations								
	Separation	Tilt	Radius/dist	Radius/dist	Apex under	Apex over			
	(µm)	(arc seconds)	under (µm)	over (µm)	(arc seconds)	(arc seconds)			
Lines	< 10 ⁻⁵	< 10 ⁻⁷							
Lines 2D	< 10 ⁻⁵	< 10 ⁻⁷							
Planes	< 10 ⁻⁵	2.4×10^{-5} data set 18							
Circles	1.8×10^{-4}	9.4×10^{-6}	5.2×10^{-5}	1.5×10^{-4}					
	data set 17	data set 24	data set 30	data set 17					
Circles 2D	3.6×10^{-4} data set 13	1.2×10^{-5} data set 14	3.2×10^{-4} data set 13	< 10 ⁻⁵	-				
	8.2×10^{-4}	uata Set 14	2.3×10^{-4}	3.6×10^{-4}					
Spheres	data set 26		2.3 × 10 data set 25	3.6 × 10 data set 26					
Cylinders	4.4×10^{-5}	7.9×10^{-4}				at a second			
	data set 4	data set 24	< 10 ⁻⁵	< 10 ⁻⁵					
Cones	9.8×10^{-2}	1.1×10^{0}	5.6×10^{-2}	9.9×10^{-4}	2.1×10^{-1}	9.9×10^{-2}			
	data set 14	data set 14	data set 14	data set 20	data set 20	data set 14			

Detailed data concerning this Special Test are available from NIST on request. For detailed descriptions of the technical approach used for these test services and specifics on the test procedures see the following references.

[1] ASME B89.4.10-2000, Methods for Performance Evaluation of Coordinate Measuring System Software, B89.4.10, American Society of Mechanical Engineers, New York, NY, 2000.

Special Test Date: May 31, 2012

Page 3 of 5

- [2] Diaz, C., Algorithm Testing and Evaluation Program for Coordinate Measuring Systems: Testing Methods, NISTIR 5686, National Institute of Standards and Technology, Gaithersburg, MD, 1995.
- [3] Diaz, C., and Hopp, T., Evaluation of Software for Coordinate Measuring Systems, proceedings of the 1995 SME Clinic, CMMs Week, June 5-8, Society of Manufacturing Engineers, Dearborn, MI; also in Proceedings of the 1995 Interface Symposium, June 21-24, Interface Foundation of North America, Carnegie Mellon University, Pittsburgh, PA.
- [4] Hopp, T. and Levenson, M., "Performance Measures for Geometric Fitting in the NIST Algorithm Testing and Evaluation Program for Coordinate Measuring Systems," *NIST Journal of Research*, **100** (5):563-574, 1995.
- [5] Rosenfeld, D., *User's Guide for the Algorithm Testing System Version 2*, NISTIR 5674, National Institute of Standards and Technology, Gaithersburg, MD, 1995.
- [6] Rosenfeld, D., *Reference Manual for the Algorithm Testing System Version* 2, NISTIR 5722, National Institute of Standards and Technology, Gaithersburg, MD, 1995.
- [7] Shakarji, C.M., Least Squares Fitting Algorithms of the NIST Algorithm Testing System, Journal of Research of the National Institute of Standards and Technology 103 (6), 633-641, 1998.
- [8] Taylor, B. N. and Kuyatt, C. E., *Guidelines for Evaluating and Expressing the Uncertainty of NIST Measurement Results*, NIST Technical Note 1297, National Institute of Standards and Technology, Gaithersburg, MD, 1994.

Special Test Date: May 31, 2012

Page 4 of 5

Test System: NIST ATS Version 2.0 on Windows XP Professional x64 Edition, Pentium III Xeon processor, 1.95 GHz.

This Report shall not be reproduced except in full without the written approval of the Large Scale Coordinate Metrology Group.

Tests were performed by Dr. Craig Shakarji. Luiy Shihiy

For the Director,

National Institute of Standards and Technology

Dr. Theodore D. Doiron, Group Leader

Dimensional Metrology Group

Semiconductor and Dimensional Metrology Division

Physical Measurement Laboratory

Special Test Date: May 31, 2012

Page 5 of 5